NSN 5910-01-249-8186

Ceramic Dielectric Fixed Capacitor - Page 1 of 2



View Online at https://aerobasegroup.com/nsn/5910-01-249-8186

Body Style: Chip type **Reliability Indicator:** Established Reliability Failure Rate Level In Percent: 0.001 **Terminal Length:** 0.020 inches **Body Length:** 0.080 inches **Body Width:** 0.050 inches **Body Height:** Between 0.020 inches and 0.055 inches **Schematic Diagram Designator:** No common or grounded electrode (s) **Insulation Resistance At Maximum Operating Temp:** 1000.0 megohms **Capacitance Value Per Section:** 27.000 picofarads single section **Nonderated Operating Temp:** Between -55.0 degrees celsius and 125.0 degrees celsius Tempurature Coefficient Of Capacitance Per Section In Ppm Per Deg Celsius: 0.0 single section Nonderated Continuous Voltage Rating And Type Per Section: 100.0 dc single section **Tolerance Of Tempurature Coefficient Per Section In Ppm Per Deg Celsius:** -30.0/+30.0 single section **Tolerance Range Per Section:** -5.00/+5.00 percent single section **Case Material:** Ceramic **Insulation Resistance At Reference Temp:** 100000.0 megohms **Dissipation Factor At Reference Tempurature In Percent:** 0.150 **Terminal Surface Treatment:** Solder **Test Data Document:** 81349-mil-c-55681 specification (includes engineering type bulletins, brochures, etc., that reflect specification type data in specification format; excludes commercial catalogs, industry directories, and similar trade publications, reflecting general type data on certain

environmental and performance requirements and test conditions that are shown as "typical", "average", "", etc.).

2 bonding pad

Terminal Type And Quantity:

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Specification Data	Spe	ecifica	ition	Data:
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81349-mil-c-55681/1 government specification

Shelf Life:

N/a

Unit Of Measure:

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Demilitarization:

No

Fiig:

A010b0